

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
2005-020399SERIAL NO.  
10/089,481INFORMATION DISCLOSURE STATEMENT  
STATEMENT BY APPLICANTAPPLICANT  
John R. Ramun

(Use several sheets if necessary)

FILING DATE  
March 28, 2002GROUP  
ART UNIT 3723

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
S	AA	5	9	4	0	9	7	1	08-24-1999	Ramun	30	134	RECEIVED AUG 22 2002 TECHNOLOGY CENTER H3700
	AB	5	9	2	6	9	5	8	07-27-1999	Ramun	30	134	
	AC	5	7	3	8	2	8	9	04-14-1998	Tagawa	241	266	
	AD	5	6	3	6	8	0	2	06-10-1997	Tagawa	241	266	
	AE	5	6	2	6	3	0	1	05-06-1997	Morikawa et al.	241	266	
	AF	5	3	5	9	7	7	5	11-01-1994	Morikawa et al.	30	134	
	AG	5	2	4	3	7	6	1	09-14-1993	Sullivan et al.	30	134	
	AH	5	1	9	9	6	5	8	04-06-1993	Bartels et al.	241	266	
	AI	5	0	6	0	3	7	8	10-29-1991	LaBounty et al.	30	134	
	AJ	5	0	4	4	5	6	9	09-03-1991	LaBounty et al.	241	266	
	AK	5	0	4	4	5	6	8	09-03-1991	Shigemizu	241	169	
	AL	4	9	0	3	4	0	8	02-27-1990	Tagawa et al.	30	228	
	AM	4	8	9	7	9	2	1	02-06-1990	Ramun	30	134	

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
													YES	NO
	AN													
	AO													
	AP													

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO		
	AP		
	AQ		

EXAMINER

Seth

DATE CONSIDERED

4/10/01

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.  
2005-020399SERIAL NO.  
10/089,481INFORMATION DISCLOSURE STATEMENT  
STATEMENT BY APPLICANTAPPLICANT  
John R. Ramun

(Use several sheets if necessary)

FILING DATE  
March 28, 2002GROUP  
ART UNIT 3723

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER							DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
	AA	4	8	9	0	7	9	8	01-02-1990	Tagawa et al.	241	266	
	AB	4	8	9	3	4	9	3	06-13-1989	LaBounty	241	101.7	
	AC	4	6	7	0	9	8	3	06-09-1987	Ramun et al.	30	134	
	AD	4	4	0	3	4	3	1	09-13-1983	Ramun et al.	37	117.5	
	AE	R	E	3	5	4	3	2	01-28-1997	LaBounty et al.	30		
	AF												
	AG												
	AH												
	AI												
	AJ												
	AK												
	AL												
	AK												

RECEIVED  
AUG 22 2002  
TECHNOLOGY CENTER R3700

## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER							DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
													YES	NO
	AL													
	AM													
	AN													

## OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

	AO													
	AP													
	AQ													

EXAMINER

S. S. S.

DATE CONSIDERED

A/C.

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.